## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10824434	YOON ET AL.
Examiner	Art Unit

2173

SEARCHED					
Class		Subclass	Date	Examiner	
715	744, 747		5/3/07 (Updated 10/15/07)	AT (AT)	

Tan, Alvin H

SEARCH NOTES				
Search Notes	Date	Examiner		
715/744-747 (text search only - see search history printout)	5/3/07 (Updated 10/15/07)	AT (AT)		
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	5/3/07 (Updated 10/15/07)	AT (AT)		
NPL - ACM Portal .	5/4/07	AT		

INTERFERENCE SEARCH			
Subclass	Date	Examiner	

U.S. Patent and Trademark Office Part of Paper No.: 20071015